

MOS FIELD EFFECT TRANSISTOR 2SK3361

SWITCHING N-CHANNEL POWER MOS FET INDUSTRIAL USE

DESCRIPTION

The 2SK3361 is N-Channel MOS Field Effect Transistor designed for high current switching application.

ORDERING INFORMATION

| PART NUMBER | PACKAGE | | |
|-------------|-----------------|--|--|
| 2SK3361 | Isolated TO-220 | | |

FEATURES

· Low on-state resistance

 $R_{DS(on)1} = 20 \text{ m}\Omega$ MAX. (Vgs = 10 V, ID = 20 A)

RDS(on)2 = 28 m Ω MAX. (VGS = 4.5 V, ID = 20 A)

- ★ Low Ciss: Ciss = 4900 pF TYP.
 - Built-in gate protection diode
 - Isolated TO-220 package

(Isolated TO-220)



ABSOLUTE MAXIMUM RATINGS ($T_A = 25$ °C)

| Drain to Source Voltage | VDSS | 100 | V |
|-------------------------------------|----------|-------------|----|
| Gate to Source Voltage | VGSS(AC) | ±20 | V |
| Gate to Source Voltage | VGSS(DC) | +20, -10 | V |
| Drain Current (DC) | ID(DC) | ±40 | Α |
| Drain Current (pulse) Note1 | D(pulse) | ±160 | Α |
| Total Power Dissipation (Tc = 25°C) | Рт | 35 | W |
| Total Power Dissipation (TA = 25°C) | Рт | 2.0 | W |
| Channel Temperature | Tch | 150 | °C |
| Storage Temperature | Tstg | -55 to +150 | °C |
| Single Avalanche Current Note2 | las | 40 | Α |
| Single Avalanche Energy Note2 | Eas | 160 | mJ |

Notes 1. PW \leq 10 μ s, Duty Cycle \leq 1 %

2. Starting T_{ch} = 25 °C, R_G = 25 Ω , V_{GS} = 20 V \rightarrow 0 V

THERMAL RESISTANCE

| Channel to Case | Rth(ch-C) | 3.57 | °C/W |
|--------------------|-----------|------|------|
| Channel to Ambient | Rth(ch-A) | 62.5 | °C/W |

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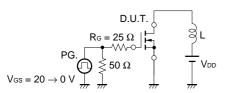
Not all devices/types available in every country. Please check with local NEC representative for availability and additional information.

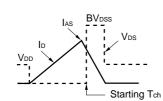


ELECTRICAL CHARACTERISTICS (TA = 25 °C)

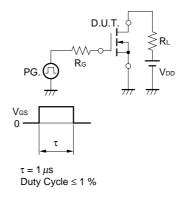
| | CHARACTERISTICS | SYMBOL | TEST CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|---|-------------------------------------|----------------------|--|------|------|------|------|
| | Drain to Source On-state Resistance | RDS(on)1 | Vgs = 10 V, Ip = 20 A | | 14 | 20 | mΩ |
| | | RDS(on)2 | $V_{GS} = 4.5 V, I_{D} = 20 A$ | | 19 | 28 | mΩ |
| * | Gate to Source Cut-off Voltage | V _{GS(off)} | $V_{DS} = 10 \text{ V}, I_{D} = 250 \mu\text{A}$ | 1.5 | 2.0 | 2.5 | V |
| * | Forward Transfer Admittance | yfs | V _{DS} = 10 V, I _D = 20 A | 18 | 36 | | S |
| | Drain Leakage Current | Ioss | V _{DS} = 100 V, V _{GS} = 0 V | | | 10 | μΑ |
| | Gate to Source Leakage Current | Igss | $V_{GS} = \pm 20 V, V_{DS} = 0 V$ | | | ±10 | μΑ |
| * | Input Capacitance | Ciss | V _{DS} = 10 V | | 4900 | | pF |
| | Output Capacitance | Coss | Vgs = 0 V | | 990 | | pF |
| | Reverse Transfer Capacitance | Crss | f = 1 MHz | | 580 | | pF |
| | Turn-on Delay Time | td(on) | ID = 20 A | | 44 | | ns |
| | Rise Time | tr | $V_{GS(on)} = 10 \text{ V}$ | | 230 | | ns |
| | Turn-off Delay Time | td(off) | $V_{DD} = 50 V$ | | 360 | | ns |
| | Fall Time | t _f | $R_G = 10 \Omega$ | | 250 | | ns |
| * | Total Gate Charge | Q _G | ID = 40 A | | 130 | | nC |
| | Gate to Source Charge | Qgs | $V_{DD} = 80 \text{ V}$ | | 14 | | nC |
| | Gate to Drain Charge | Q _{GD} | $V_{GS(on)} = 10 \text{ V}$ | | 50 | | nC |
| * | Body Diode Forward Voltage | VF(S-D) | $I_F = 40 A, V_{GS} = 0 V$ | | 0.92 | | V |
| | Reverse Recovery Time | trr | IF = 40 A, VGS = 0 V | | 170 | | ns |
| | Reverse Recovery Charge | Qrr | $di/dt = 100 A/\mu s$ | | 870 | | nC |

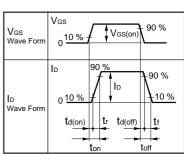
TEST CIRCUIT 1 AVALANCHE CAPABILITY



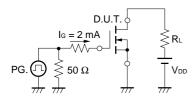


TEST CIRCUIT 2 SWITCHING TIME





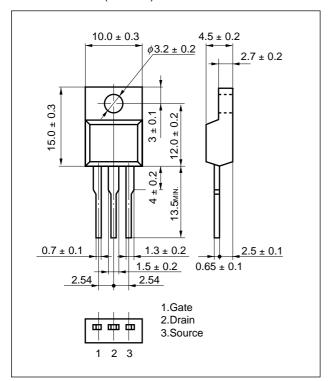
TEST CIRCUIT 3 GATE CHARGE



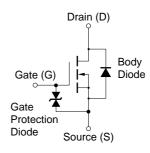


PACKAGE DRAWING (Unit: mm)

Isolated TO-220 (MP-45F)



EQUIVALENT CIRCUIT



Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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